

R M 1 2 4 A / R A D. T E S T K E Y

TEST # 800, "START-UP CHECK; STR(UP), V+=2.5V, V-=0V"

TEST # 900, "CONTINUITY TEST"

I=1 TO 4

TEST # 1000*I+1, "INPUT OFFSET VOLTAGE; VIO, V+=30V, VCM=-15V"

TEST # 1000*I+2, "INPUT OFFSET VOLTAGE; VIO, V+=2V, V=-28V, VCM=13V"

TEST # 1000*I+3, "INPUT OFFSET VOLTAGE; VIO, V+=5V, V-=0V, VCM=-1.4V"

TEST # 1000*I+4, "INPUT OFFSET VOLTAGE; VIO, V+=2.5V, V=-2.5V, VCM=1.1V"

TEST # 1000*I+5, "INPUT OFFSET CURRENT; IIO, V+=30V, VCM=-15V"

TEST # 1000*I+6, "INPUT OFFSET CURRENT; IIO, V+=2V, V=-28V, VCM=13V"

TEST # 1000*I+7, "INPUT OFFSET CURRENT; IIO, V+=5V, V-=0V, VCM=-1.4V"

TEST # 1000*I+8, "INPUT OFFSET CURRENT; IIO, V+=2.5V, V=-2.5V, VCM=1.1V"

TEST # 1000*I+9, "+INPUT BIAS CURRENT; +IIB, V+=30V, VCM=-15V"

TEST # 1000*I+10, "+INPUT BIAS CURRENT; +IIB, V+=2V, V=-28V, VCM=13V"

TEST # 1000*I+11, "+INPUT BIAS CURRENT; +IIB, V+=5V, V-=0V, VCM=-1.4V"

TEST # 1000*I+12, "+Input BIAS CURRENT; +IIB, V+=2.5V, V=-2.5V, VCM=1.1V"

TEST # 1000*I+13, "-INPUT BIAS CURRENT; -IIB, V+=30V, VCM=-15V"

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TEST # 1000*I+14, "-INPUT BIAS CURRENT; -IIB, V+=2V, V-=-28V, VCM=13V"

TEST # 1000*I+15, "-INPUT BIAS CURRENT; -IIB, V+=5V, V-=0V, VCM=-1.4V"

TEST # 1000*I+16, "-INPUT BIAS CURRENT; -IIB, V+=2.5V, V-=-2.5V, VCM=1.1V"

TEST # 1000*I+17, "+PSRR; V-=0V, V+=5V TO 30V, VCM=-1.4V"

TEST # 1000*I+18, "COMM MODE REJ RATIO; CMRR, VCM=13V TO -15V"

TEST # 1000*I+19, "+O/P SHORT CIRCUIT CURR; +IOS, V+=30V, V-=0V, VO=25V"

TEST # 61, "POWER SUPPLY CURRENT; ICC, V+=30V, V-=0V"

TEST # 1000*I+20, "+O/P VOLT SWING; V+=30V, V-=0V, VO=30V, RL=10K"

TEST # 1000*I+21, "+O/P VOLT SWING; V+=30V, V-=0V, VO=30V, RL=2K"

TEST # 1000*I+22, "VOLT GAIN; AVS, VO=1V TO 26V, V+=30V, V-=0V, RL=10K"

TEST # 1000*I+23, "VOLT GAIN; AVS, VO=5V TO 20V, V+=30V, V-=0V, RL=2K"

TEST # 1000*I+24, "VOLT GAIN; AVS, VO=1V TO 2.5V, V+=5V, V-=0V, RL=10K"

TEST # 1000*I+25, "VOLT GAIN; AVS, VO=1V TO 2.5V, V+=5V, V-=0V, RL=2K"

TEST # 1000*I+26, "O/P VOLTAGE LOGICAL LOW; V+=30V, V-=0V, RL=10K"

TEST # 1000*I+27, "O/P VOLTAGE LOGICAL LOW; V+=30V, V-=0V, IOL=5MA"

TEST # 1000*I+28, "O/P VOLTAGE LOGICAL LOW; V+=4.5V, V-=0V, IOL=2UA"

TEST # 1000*I+29, "O/P VOLTAGE LOGICAL HIGH; V+=30V, V-=0V, IOH=-10MA"

TEST # 1000*I+30, "O/P VOLTAGE LOGICAL HIGH; V+=4.5V, V-=0V, IOH=-10MA"

TEST # 1000*I+31, "RISE TIME; TR(tr), V+=30V, V-=-0V"

TEST # 1000*I+32, "RISE TIME; TR(os), V+=30V, V-=-0V"

TEST # 1000*I+33, "SLEW RATE+; SR+, V+=30V, V-=-0V"

TEST # 1000*I+34, "SLEW RATE-; SR-, V+=30V, V-=-0V"